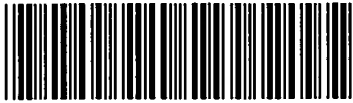


Search Notes

Application/Control No.

09/760,879

Examiner

Justin Y. Lee

Applicant(s)/Patent under
Reexamination

TAKAE ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
Same	Previous Search	1/26/2007	JL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	1/26/2007	JL
Duc Nguyen	1/29/2007	JL